

N-Channel 60 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | |
|---------------------|---------------------------------|---------------------------------|-----------------------|--|--|
| V _{DS} (V) | R _{DS(on)} (mΩ) (Typ.) | I _D (A) ^a | Q _g (Typ.) | | |
| 60 | 74 at V _{GS} = 10 V | 20 | 7.2 nC | | |
| | 78 at V _{GS} = 4.5 V | 13 | | | |

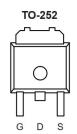
FEATURES

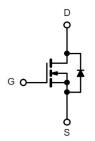
- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

• DC/DC Converters





N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted) | | | | | |
|--|-----------------------------------|------------------|------------------|----|--|
| Parameter | Symbol | Limit | Unit | | |
| Drain-Source Voltage | | V _{DS} | 60 | V | |
| Gate-Source Voltage | | V _{GS} | ± 20 | | |
| | T _C = 25 °C | I _D | 20 | | |
| Continuous Drain Current (T _J = 150 °C) | T _C = 70 °C | | 12.1 | | |
| Continuous Diam Current (1) = 130 C) | T _A = 25 °C | | 9.1 ^a | | |
| | T _A = 70 °C | | 7.6 ^a | A | |
| Pulsed Drain Current | | I _{DM} | 60 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | I _S | 17.8 | | |
| Continuous Source-Diam Diode Current | T _A = 25 °C | 'S | 3.8 ^a | | |
| Single Pulse Avalanche Current | L = 0.1 mH | I _{AS} | 18 |] | |
| Avalanche Energy | E = 0.1 IIII1 | E _{AS} | 26 | mJ | |
| | T _C = 25 °C | - P _D | 31.25 | | |
| Maximum Power Dissipation | T _C = 70 °C | | 20 | W | |
| | T _A = 25 °C | | 5.7 ^a | | |
| | T _A = 70 °C |] | 3.6 ^a |] | |
| Operating Junction and Storage Temperature Range | T _J , T _{stg} | - 55 to 150 | °C | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|--|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^a | t ≤ 10 s | R _{thJA} | 18 | 22 | °C/W | |
| Maximum Junction-to-Case | Steady State | R _{thJC} | 3.2 | 4.0 | | |

Notes:

a. Surface mounted on 1" x 1" FR4 board, $t \le 10 \text{ s.}$

Rev. 1. 0



| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
|---|-------------------------|---|------|----------|--------------|----------|--|
| Static | | | | <u>'</u> | ' | ' | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = 250 μA | 60 | | | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | L = 250A | | 65 | | mV/°C | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = 250 μA | | - 6.3 | | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 1.0 | | 3.0 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA | |
| 7 6 2 2 2 2 2 2 2 | I _{DSS} | V _{DS} = 60 V, V _{GS} = 0 V | 1.0 | | 1.0 | , | |
| Zero Gate Voltage Drain Current | | V _{DS} = 60 V, V _{GS} = 0 V, T _J = 70 °C | | | 20 | μA | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 50 | | | Α | |
| Drain-Source On-State Resistance ^a | | V _{GS} = 10 V, I _D = 8 A | | 74 | 81 | Ω | |
| | R _{DS(on)} | V _{GS} = 4.5 V, I _D = 6 A | | 78 | 89 | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 8 A | | 15 | | S | |
| Dynamic ^b | | | | ' | | | |
| Input Capacitance | C _{iss} | | | 262 | | pF | |
| Output Capacitance | C _{oss} | V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz | | 25 | | | |
| Reverse Transfer Capacitance | C _{rss} | | | 19 | | | |
| Total Gate Charge | Qg | | | 7.2 | | nC | |
| Gate-Source Charge | Q _{gs} | V _{DS} = 10 V, V _{GS} = 10 V, I _D = 8 A | | 1.0 | | | |
| Gate-Drain Charge | Q _{gd} | | | 2.3 | | | |
| Gate Resistance | R _g | f = 1 MHz | | 1.6 | | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 15 | | - ns | |
| Rise Time | t _r | $V_{DD} = 30 \text{ V, R}_{1} = 1.3 \Omega$ | | 240 | | | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong 8 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ | | 32 | | | |
| Fall Time | t _f | | | 64 | | | |
| Turn-On Delay Time | t _{d(on)} | | | 6 | | | |
| Rise Time | t _r | $V_{DD} = 30 \text{ V, R}_{1} = 1.3 \Omega$ | | 13 | | | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong 8 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$ | | 27 | | | |
| Fall Time | t _f | | | 23 | | | |
| Drain-Source Body Diode Characteris | tics | | | | | | |
| Continuous Source-Drain Diode Current | Is | T _C = 25 °C | | | 20 | A | |
| Pulse Diode Forward Current ^a | I _{SM} | | | | 60 |] ^ | |
| Body Diode Voltage | V _{SD} | I _S = 1 A | | | 1.2 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | | | 25 | 60 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 8 A, dl/dt = 100 A/μs, T _J = 25 °C | | 31 | 70 | nC | |
| Reverse Recovery Fall Time | IF = 0 A 01/01 = 10 | | 25 C | | | w | |
| Reverse Recovery Rise Time | t _b | | | 8 | | ns | |

Notes

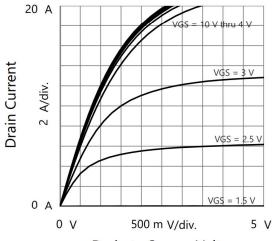
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

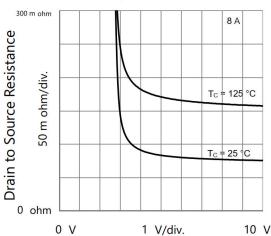
b. Guaranteed by design, not subject to production testing.



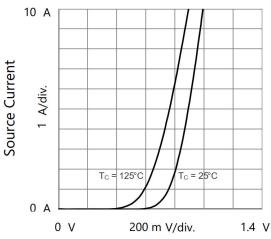
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



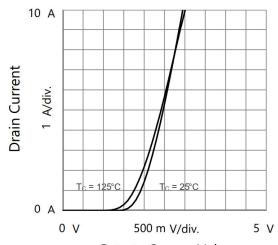
Drain to Source Voltage Output Characteristics



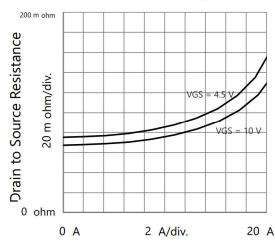
Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage



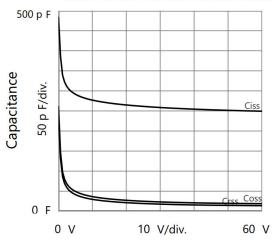
Source to Drain Voltage Body Diode Forward Characteristics



Gate to Source Voltage Transfer Characteristics



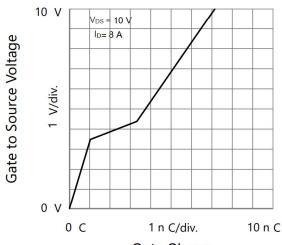
Drain Current
Drain to Source Resistance vs. Drain Current



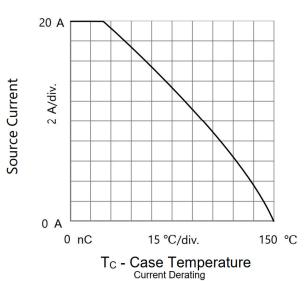
Drain to Source Voltage Capacitances

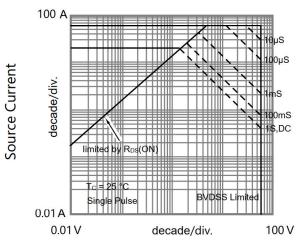


TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

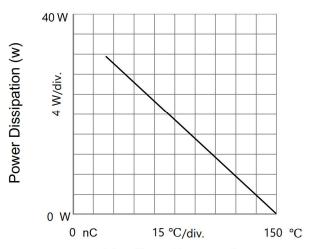








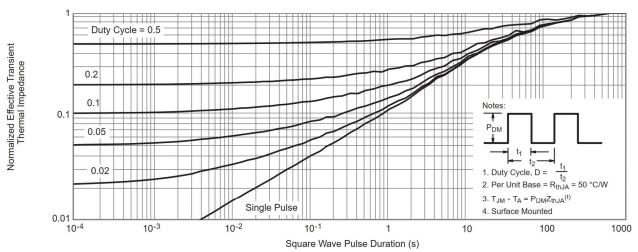
Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



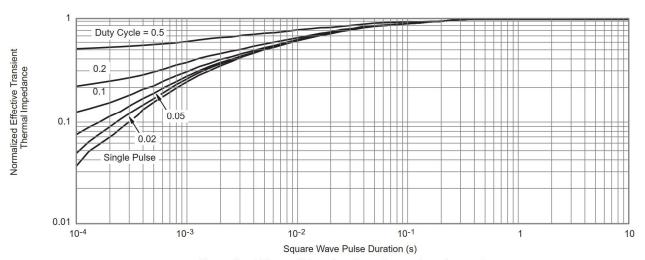
 $T_{C} \textbf{-} \textbf{Case Temperature}_{\text{Current Derating}}$



TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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